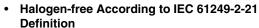


# SFS9540-VB Datasheet P-Channel 100 V (D-S) MOSFET

| PRODUC              | RODUCT SUMMARY                     |                    |                       |  |  |
|---------------------|------------------------------------|--------------------|-----------------------|--|--|
| V <sub>DS</sub> (V) | $R_{DS(on)}(\Omega)$               | I <sub>D</sub> (A) | Q <sub>g</sub> (Typ.) |  |  |
| - 100               | 0.220 at V <sub>GS</sub> = - 10 V  | - 12               | 11.7                  |  |  |
| - 100               | 0.230 at V <sub>GS</sub> = - 4.5 V | - 10               | 11.7                  |  |  |

#### **FEATURES**

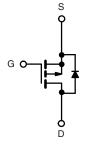




- Trench Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested
- Compliant to RoHS Directive 2002/95/EC

## **APPLICATIONS**

- Power Switch
- DC/DC Converters



P-Channel MOSFET

| G D S    |
|----------|
| Top View |

**TO-220 FULLPAK** 

| ABSOLUTE MAXIMUM RATING                            | <b>S</b> $T_C$ = 25 °C, unless othe | rwise noted                       |                   |      |  |
|--|-------------------------------------|-----------------------------------|-------------------|------|--|
| Parameter  |                                     | Symbol                            | Limit             | Unit |  |
| Drain-Source Voltage                               |                                     | V <sub>DS</sub>                   | - 100             | v    |  |
| Gate-Source Voltage                                |                                     | V <sub>GS</sub>                   | ± 20              |      |  |
| Continuous Drain Current (T <sub>J</sub> = 150 °C) | T <sub>C</sub> = 25 °C              | = 25 °C - 12                      |                   |      |  |
| Continuous Diam Current (1) = 150 C)               | T <sub>C</sub> = 70 °C              |                                   | - 8.6             | Δ.   |  |
| Pulsed Drain Current                               |                                     | I <sub>DM</sub>                   | - 36              | A    |  |
| Avalanche Current                                  |                                     | I <sub>AS</sub>                   | - 18              |      |  |
| Single Avalanche Energy <sup>a</sup> L = 0.1 mH    |                                     | E <sub>AS</sub>                   | 16.2              | mJ   |  |
|  | T <sub>C</sub> = 25 °C              | D                                 | 38.1 <sup>b</sup> | 14/  |  |
| Maximum Power Dissipation <sup>a</sup>             | T <sub>A</sub> = 25 °C <sup>c</sup> | P <sub>D</sub>                    | 2.5               | W    |  |
| Operating Junction and Storage Temperature Range   |                                     | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 150       | °C   |  |

| THERMAL RESISTANCE RATINGS                   |                   |       |      |
|--|-------------------|-------|------|
| Parameter                                    | Symbol            | Limit | Unit |
| Junction-to-Ambient (PCB Mount) <sup>c</sup> | R <sub>thJA</sub> | 50    | °C/W |
| Junction-to-Case (Drain)                     | R <sub>thJC</sub> | 3.9   |      |

#### Notes:

- a. Duty cycle  $\leq$  1 %.
- b. See SOA curve for voltage derating.
- c. When Mounted on 1" square PCB (FR-4 material).



| Parameter                                     | Symbol               | Test Conditions  | Min.  | Тур.  | Max.  | Unit |
|---|----------------------|--|-------|-------|-------|------|
| Static  | <u> </u>             |  |       |       |       |      |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>      | $V_{DS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$                             | - 100 |       |       | V    |
| Gate Threshold Voltage                        | V <sub>GS(th)</sub>  | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$  | - 1   |       | - 2.5 |      |
| Gate-Body Leakage                             | I <sub>GSS</sub>     | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$                            |       |       | ± 250 | nA   |
|   | I <sub>DSS</sub>     | V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V                             |       |       | - 1   | μΑ   |
| Zero Gate Voltage Drain Current               |                      | V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C    |       |       | - 50  |      |
| Š   |                      | V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C    |       |       | - 250 |      |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>   | $V_{DS} \le -10 \text{ V}, V_{GS} = -10 \text{ V}$                           | - 15  |       |       | Α    |
|   | Ь                    | V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 3.6 A                           |       | 0.220 |       |      |
| Drain-Source On-State Resistance <sup>a</sup> | R <sub>DS(on)</sub>  | V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 3.4 A                          |       | 0.230 |       | Ω    |
| Forward Transconductance <sup>a</sup>         | 9 <sub>fs</sub>      | V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 3.6 A                           |       | 12    |       | S    |
| Dynamic <sup>b</sup>                          | •                    |  |       | •     |       |      |
| Input Capacitance                             | C <sub>iss</sub>     |  |       | 1055  |       | pF   |
| Output Capacitance                            | C <sub>oss</sub>     | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = - 50 V, f = 1 MHz                   |       | 65    |       |      |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>     | 1  |       | 41    |       |      |
| Total Ooks Observed                           |                      | V <sub>DS</sub> = - 50 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 3.6 A |       | 23.2  | 34.8  |      |
| Total Gate Charge <sup>c</sup>                | Qg                   |  |       | 11.7  | 17.6  | 0    |
| Gate-Source Charge <sup>c</sup>               | $Q_{gs}$             | $V_{DS} = -50 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -3.6 \text{ A}$    |       | 3.5   |       | nC   |
| Gate-Drain Charge <sup>c</sup>                | Q <sub>gd</sub>      |  |       | 4.8   |       |      |
| Gate Resistance                               | $R_g$                | f = 1 MHz  | 1.2   | 5.7   | 11.5  | Ω    |
| Turn-On Delay Time <sup>c</sup>               | t <sub>d(on)</sub>   |  |       | 7     | 14    |      |
| Rise Time <sup>c</sup>                        | t <sub>r</sub>       | $V_{DD} = -50 \text{ V}, R_L = 17.2 \Omega$                                  |       | 12    | 18    | ns   |
| Turn-Off Delay Time <sup>c</sup>              | t <sub>d(off)</sub>  | $I_D \cong$ - 2.9 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$                  |       | 33    | 50    |      |
| Fall Time <sup>c</sup>                        | t <sub>f</sub>       | 1  |       | 9     | 18    |      |
| Drain-Source Body Diode Ratings ar            | nd Characteri        | stics T <sub>C</sub> = 25 °C <sup>b</sup>                                    |       |       |       |      |
| Continuous Current                            | Is                   |  |       |       | - 8.8 | А    |
| Pulsed Current                                | I <sub>SM</sub>      |  |       |       | - 15  |      |
| Forward Voltage <sup>a</sup>                  | V <sub>SD</sub>      | I <sub>F</sub> = - 2.9 A, V <sub>GS</sub> = 0 V                              |       | - 0.8 | - 1.5 | V    |
| Reverse Recovery Time                         | t <sub>rr</sub>      |  |       | 50    | 75    | ns   |
| Peak Reverse Recovery Current                 | I <sub>RM(REC)</sub> | I <sub>F</sub> = - 2.9 A, dl/dt = 100 A/μs                                   |       | - 4   | - 6   | Α    |
| Reverse Recovery Charge                       | Q <sub>rr</sub>      | † †  |       | 98    | 147   | nC   |

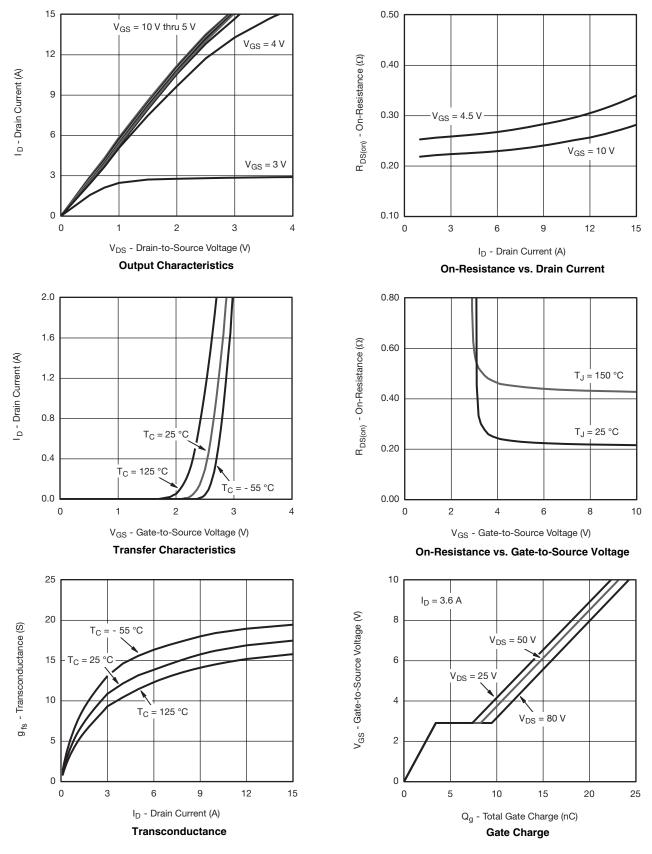
#### Notes:

- a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

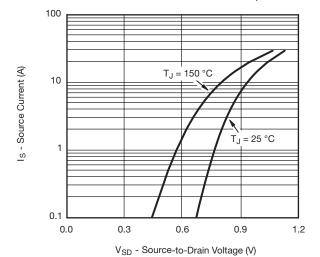


## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

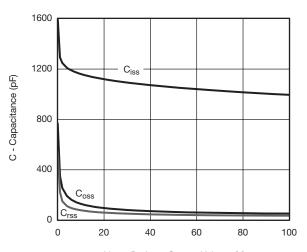




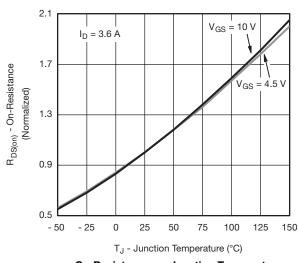
## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Source-Drain Diode Forward Voltage

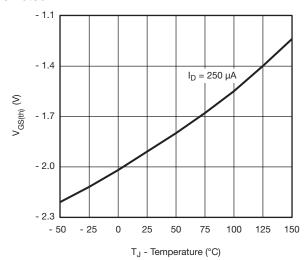


 $V_{DS}$  - Drain-to-Source Voltage (V)  $\label{eq:capacitance}$ 

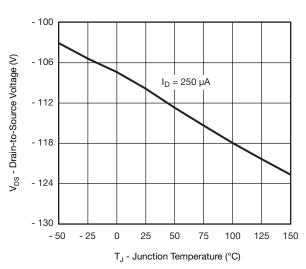


On-Resistance vs. Junction Temperature

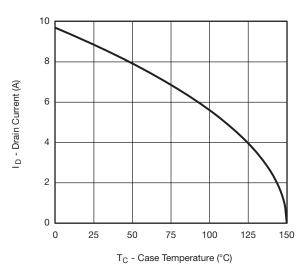
4



Threshold Voltage



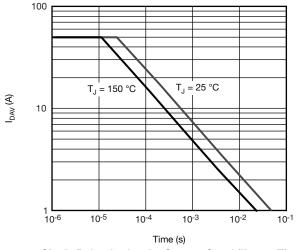
Drain Source Breakdown vs. Junction Temperature

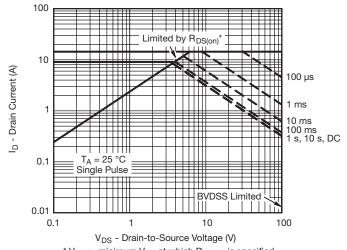


**Current Derating** 

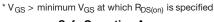


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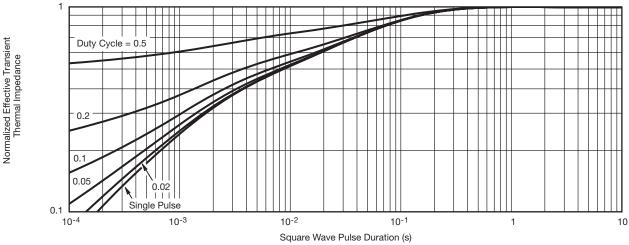




Single Pulse Avalanche Current Capability vs. Time







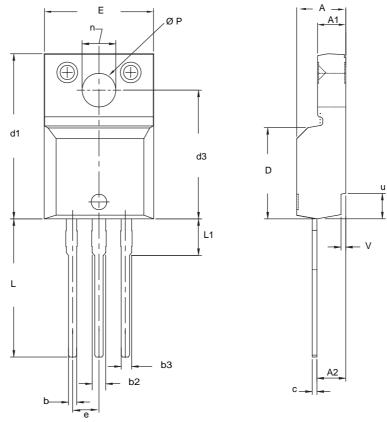
Normalized Thermal Transient Impedance, Junction-to-Case

服务热线:400-655-8788

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## **TO-220 FULLPAK**



|           | INCHES |  |  |
|-----------|--------|--|--|
| MIN.      | MAX.   |  |  |
| 0.180     | 0.190  |  |  |
| 0.101     | 0.111  |  |  |
| 0.099     | 0.112  |  |  |
| 0.024     | 0.035  |  |  |
| 0.048     | 0.055  |  |  |
| 0.048     | 0.055  |  |  |
| 0.017     | 0.025  |  |  |
| 0.341     | 0.386  |  |  |
| 0.622     | 0.635  |  |  |
| 0.484     | 0.509  |  |  |
| 0.408     | 0.419  |  |  |
| 0.100 BSC |        |  |  |
| 0.520     | 0.541  |  |  |
| 0.122     | 0.138  |  |  |
| 0.238     | 0.242  |  |  |
| 0.120     | 0.136  |  |  |
| 0.094     | 0.098  |  |  |
| 0.016     | 0.020  |  |  |
|           |        |  |  |

### Notes

- To be used only for process drawing.
   These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
   All critical dimensions should C meet C<sub>pk</sub> > 1.33.
   All dimensions include burrs and plating thickness.
   No chipping or package damage.



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